



NSAI
Standards

Irish Standard
I.S. EN 61000-4-10:2017

Electromagnetic compatibility (EMC) - Part 4-10: Testing and measurement techniques - Damped oscillatory magnetic field immunity test

I.S. EN 61000-4-10:2017

Incorporating amendments/corrigenda/National Annexes issued since publication:

The National Standards Authority of Ireland (NSAI) produces the following categories of formal documents:

I.S. xxx: Irish Standard — national specification based on the consensus of an expert panel and subject to public consultation.

S.R. xxx: Standard Recommendation — recommendation based on the consensus of an expert panel and subject to public consultation.

SWiFT xxx: A rapidly developed recommendatory document based on the consensus of the participants of an NSAI workshop.

This document replaces/revises/consolidates the NSAI adoption of the document(s) indicated on the CEN/CENELEC cover/Foreword and the following National document(s):

NOTE: The date of any NSAI previous adoption may not match the date of its original CEN/CENELEC document.

This document is based on:

EN 61000-4-10:2017

Published:

2017-02-24

This document was published under the authority of the NSAI and comes into effect on:

2017-03-14

ICS number:

33.100.20

NOTE: If blank see CEN/CENELEC cover page

NSAI
1 Swift Square,
Northwood, Santry
Dublin 9

T +353 1 807 3800
F +353 1 807 3838
E standards@nsai.ie
W NSAI.ie

Sales:
T +353 1 857 6730
F +353 1 857 6729
W standards.ie

Údarás um Chaighdeáin Náisiúnta na hÉireann

National Foreword

I.S. EN 61000-4-10:2017 is the adopted Irish version of the European Document EN 61000-4-10:2017, Electromagnetic compatibility (EMC) - Part 4-10: Testing and measurement techniques - Damped oscillatory magnetic field immunity test

This document does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

Compliance with this document does not of itself confer immunity from legal obligations.

In line with international standards practice the decimal point is shown as a comma (,) throughout this document.

This page is intentionally left blank

EUROPEAN STANDARD

EN 61000-4-10

NORME EUROPÉENNE

EUROPÄISCHE NORM

February 2017

ICS 33.100.20

Supersedes EN 61000-4-10:1993

English Version

**Electromagnetic compatibility (EMC) -
Part 4-10: Testing and measurement techniques - Damped
oscillatory magnetic field immunity test
(IEC 61000-4-10:2016)**

Compatibilité électromagnétique (CEM) -
Partie 4-10: Techniques d'essai et de mesure - Essai
d'immunité du champ magnétique oscillatoire amorti
(IEC 61000-4-10:2016)

Elektromagnetische Verträglichkeit (EMV) -
Teil 4-10: Prüf- und Messverfahren - Prüfung der
Störfestigkeit gegen gedämpft schwingende Magnetfelder
(IEC 61000-4-10:2016)

This European Standard was approved by CENELEC on 2016-08-11. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the CEN-CENELEC Management Centre has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Bulgaria, Croatia, Cyprus, the Czech Republic, Denmark, Estonia, Finland, Former Yugoslav Republic of Macedonia, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, the Netherlands, Norway, Poland, Portugal, Romania, Serbia, Slovakia, Slovenia, Spain, Sweden, Switzerland, Turkey and the United Kingdom.



European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Avenue Marnix 17, B-1000 Brussels

EN 61000-4-10:2017

European foreword

The text of document 77B/730/CDV, future edition 2 of IEC 61000-4-10, prepared by SC 77B "High frequency phenomena" of IEC/TC 77 "Electromagnetic compatibility" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 61000-4-10:2017.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2017-08-24
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2020-02-24

This document supersedes EN 61000-4-10:1993.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. CENELEC [and/or CEN] shall not be held responsible for identifying any or all such patent rights.

Endorsement notice

The text of the International Standard IEC 61000-4-10:2016 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following note has to be added for the standard indicated:

IEC 61000-4-18 NOTE Harmonized as EN 61000-4-18.

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu

| <u>Publication</u> | <u>Year</u> | <u>Title</u> | <u>EN/HD</u> | <u>Year</u> |
|--------------------|-------------|---|--------------|-------------|
| IEC 60050 | Series | International Electrotechnical Vocabulary (IEV) | - | - |

This page is intentionally left blank



IEC 61000-4-10

Edition 2.0 2016-07

INTERNATIONAL STANDARD

NORME INTERNATIONALE



BASIC EMC PUBLICATION
PUBLICATION FONDAMENTALE EN CEM

**Electromagnetic compatibility (EMC) –
Part 4-10: Testing and measurement techniques – Damped oscillatory magnetic
field immunity test**

**Compatibilité électromagnétique (CEM) –
Partie 4-10: Techniques d'essai et de mesure – Essai d'immunité du champ
magnétique oscillatoire amorti**





THIS PUBLICATION IS COPYRIGHT PROTECTED

Copyright © 2016 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester. If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

Droits de reproduction réservés. Sauf indication contraire, aucune partie de cette publication ne peut être reproduite ni utilisée sous quelque forme que ce soit et par aucun procédé, électronique ou mécanique, y compris la photocopie et les microfilms, sans l'accord écrit de l'IEC ou du Comité national de l'IEC du pays du demandeur. Si vous avez des questions sur le copyright de l'IEC ou si vous désirez obtenir des droits supplémentaires sur cette publication, utilisez les coordonnées ci-après ou contactez le Comité national de l'IEC de votre pays de résidence.

IEC Central Office
3, rue de Varembe
CH-1211 Geneva 20
Switzerland

Tel.: +41 22 919 02 11
Fax: +41 22 919 03 00
info@iec.ch
www.iec.ch

About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigenda or an amendment might have been published.

IEC Catalogue - webstore.iec.ch/catalogue

The stand-alone application for consulting the entire bibliographical information on IEC International Standards, Technical Specifications, Technical Reports and other documents. Available for PC, Mac OS, Android Tablets and iPad.

IEC publications search - www.iec.ch/searchpub

The advanced search enables to find IEC publications by a variety of criteria (reference number, text, technical committee,...). It also gives information on projects, replaced and withdrawn publications.

IEC Just Published - webstore.iec.ch/justpublished

Stay up to date on all new IEC publications. Just Published details all new publications released. Available online and also once a month by email.

Electropedia - www.electropedia.org

The world's leading online dictionary of electronic and electrical terms containing 20 000 terms and definitions in English and French, with equivalent terms in 15 additional languages. Also known as the International Electrotechnical Vocabulary (IEV) online.

IEC Glossary - std.iec.ch/glossary

65 000 electrotechnical terminology entries in English and French extracted from the Terms and Definitions clause of IEC publications issued since 2002. Some entries have been collected from earlier publications of IEC TC 37, 77, 86 and CISPR.

IEC Customer Service Centre - webstore.iec.ch/csc

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: csc@iec.ch.

A propos de l'IEC

La Commission Electrotechnique Internationale (IEC) est la première organisation mondiale qui élabore et publie des Normes internationales pour tout ce qui a trait à l'électricité, à l'électronique et aux technologies apparentées.

A propos des publications IEC

Le contenu technique des publications IEC est constamment revu. Veuillez vous assurer que vous possédez l'édition la plus récente, un corrigendum ou amendement peut avoir été publié.

Catalogue IEC - webstore.iec.ch/catalogue

Application autonome pour consulter tous les renseignements bibliographiques sur les Normes internationales, Spécifications techniques, Rapports techniques et autres documents de l'IEC. Disponible pour PC, Mac OS, tablettes Android et iPad.

Recherche de publications IEC - www.iec.ch/searchpub

La recherche avancée permet de trouver des publications IEC en utilisant différents critères (numéro de référence, texte, comité d'études,...). Elle donne aussi des informations sur les projets et les publications remplacées ou retirées.

IEC Just Published - webstore.iec.ch/justpublished

Restez informé sur les nouvelles publications IEC. Just Published détaille les nouvelles publications parues. Disponible en ligne et aussi une fois par mois par email.

Electropedia - www.electropedia.org

Le premier dictionnaire en ligne de termes électroniques et électriques. Il contient 20 000 termes et définitions en anglais et en français, ainsi que les termes équivalents dans 15 langues additionnelles. Egalement appelé Vocabulaire Electrotechnique International (IEV) en ligne.

Glossaire IEC - std.iec.ch/glossary

65 000 entrées terminologiques électrotechniques, en anglais et en français, extraites des articles Termes et Définitions des publications IEC parues depuis 2002. Plus certaines entrées antérieures extraites des publications des CE 37, 77, 86 et CISPR de l'IEC.

Service Clients - webstore.iec.ch/csc

Si vous désirez nous donner des commentaires sur cette publication ou si vous avez des questions contactez-nous: csc@iec.ch.



IEC 61000-4-10

Edition 2.0 2016-07

INTERNATIONAL STANDARD

NORME INTERNATIONALE



BASIC EMC PUBLICATION
PUBLICATION FONDAMENTALE EN CEM

**Electromagnetic compatibility (EMC) –
Part 4-10: Testing and measurement techniques – Damped oscillatory magnetic
field immunity test**

**Compatibilité électromagnétique (CEM) –
Partie 4-10: Techniques d'essai et de mesure – Essai d'immunité du champ
magnétique oscillatoire amorti**

INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

COMMISSION
ELECTROTECHNIQUE
INTERNATIONALE

ICS 33.100.20

ISBN 978-2-8322-3501-0

**Warning! Make sure that you obtained this publication from an authorized distributor.
Attention! Veuillez vous assurer que vous avez obtenu cette publication via un distributeur agréé.**

CONTENTS

| | |
|---|----|
| FOREWORD..... | 5 |
| INTRODUCTION..... | 7 |
| 1 Scope and object..... | 8 |
| 2 Normative references..... | 8 |
| 3 Terms, definitions and abbreviated terms..... | 9 |
| 3.1 Terms and definitions..... | 9 |
| 3.2 Abbreviations..... | 10 |
| 4 General..... | 10 |
| 5 Test levels..... | 10 |
| 6 Test instrumentation..... | 11 |
| 6.1 General..... | 11 |
| 6.2 Damped oscillatory wave generator..... | 11 |
| 6.2.1 General..... | 11 |
| 6.2.2 Performance characteristics of the generator connected to the standard induction coil..... | 12 |
| 6.3 Standard induction coil..... | 14 |
| 6.4 Calibration of the test system..... | 14 |
| 7 Test setup..... | 15 |
| 7.1 Test equipment..... | 15 |
| 7.2 Verification of the test instrumentation..... | 15 |
| 7.3 Test setup for table-top EUT..... | 16 |
| 7.4 Test setup for floor standing EUT..... | 16 |
| 7.5 Test setup for damped oscillatory field applied in-situ..... | 18 |
| 8 Test procedure..... | 18 |
| 8.1 General..... | 18 |
| 8.2 Laboratory reference conditions..... | 18 |
| 8.2.1 Climatic conditions..... | 18 |
| 8.2.2 Electromagnetic conditions..... | 18 |
| 8.3 Execution of the test..... | 19 |
| 9 Evaluation of test results..... | 19 |
| 10 Test report..... | 20 |
| Annex A (informative) Information on the field distribution of standard induction coils..... | 21 |
| A.1 General..... | 21 |
| A.2 Determination of the coil factor..... | 21 |
| A.2.1 General..... | 21 |
| A.2.2 Coil factor calculation..... | 21 |
| A.3 1 m × 1 m standard induction coil..... | 22 |
| A.4 1 m × 2,6 m standard induction coil with reference ground plane..... | 23 |
| A.5 1 m × 2,6 m standard induction coil without reference ground plane..... | 24 |
| Annex B (informative) Selection of the test levels..... | 26 |
| Annex C (informative) Damped oscillatory magnetic field frequency..... | 28 |
| Annex D (informative) Measurement uncertainty (MU) considerations..... | 29 |
| D.1 General..... | 29 |
| D.2 Legend..... | 29 |

| | | |
|-----------------------|---|----|
| D.3 | Uncertainty contributors to the peak current and to the damped oscillatory magnetic field measurement uncertainty | 29 |
| D.4 | Uncertainty of peak current and damped oscillatory magnetic field calibration | 30 |
| D.4.1 | General..... | 30 |
| D.4.2 | Peak current | 30 |
| D.4.3 | Further MU contributions to amplitude and time measurements | 32 |
| D.4.4 | Rise time of the step response and bandwidth of the frequency response of the measuring system | 32 |
| D.4.5 | Impulse peak distortion due to the limited bandwidth of the measuring system..... | 33 |
| D.5 | Application of uncertainties in the damped oscillatory wave generator compliance criterion | 34 |
| Annex E (informative) | 3D numerical simulations | 35 |
| E.1 | General..... | 35 |
| E.2 | Simulations | 35 |
| E.3 | Comments | 35 |
| Bibliography | | 41 |
| Figure 1 | – Simplified schematic circuit of the test generator for damped oscillatory magnetic field | 12 |
| Figure 2 | – Waveform of short-circuit current in the standard coils | 13 |
| Figure 3 | – Waveform of short-circuit current showing the repetition time T_{rep} | 13 |
| Figure 4 | – Example of a current measurement of standard induction coils..... | 14 |
| Figure 5 | – Example of test setup for table-top equipment..... | 16 |
| Figure 6 | – Example of test setup for floor standing equipment showing the horizontal orthogonal plane..... | 17 |
| Figure 7 | – Example of test setup for floor standing equipment showing the vertical orthogonal plane..... | 17 |
| Figure 8 | – Example of test setup using the proximity method | 18 |
| Figure A.1 | – Rectangular induction coil with sides $a + b$ and c | 22 |
| Figure A.2 | – +3 dB isoline for the magnetic field strength (magnitude) in the x - y plane for the 1 m × 1 m induction coil | 22 |
| Figure A.3 | – +3 dB and –3 dB isolines for the magnetic field strength (magnitude) in the x - z plane for the 1 m × 1 m induction coil | 23 |
| Figure A.4 | – +3 dB isoline for the magnetic field strength (magnitude) in the x - z plane for the 1 m × 2,6 m induction coil with reference ground plane | 23 |
| Figure A.5 | – +3 dB and –3 dB isolines for the magnetic field strength (magnitude) in the x - y plane for the 1 m × 2,6 m induction coil with reference ground plane | 24 |
| Figure A.6 | – +3 dB isoline for the magnetic field strength (magnitude) in the x - y plane for the 1 m × 2,6 m induction coil without reference ground plane | 24 |
| Figure A.7 | – +3 dB and –3 dB isolines for the magnetic field strength (magnitude) in the x - z plane for the 1 m × 2,6 m induction coil without reference ground plane | 25 |
| Figure E.1 | – Current with period of 1 μ s and H-field in the center of the 1 m × 1 m standard induction coil | 36 |
| Figure E.2 | – H_x -field along the side of 1 m × 1 m standard induction coil in A/m | 36 |
| Figure E.3 | – H_x -field in direction x perpendicular to the plane of the 1 m × 1 m standard induction coil | 37 |
| Figure E.4 | – H_x -field along the side in dB for 1 m × 1 m standard induction coil | 37 |

| | |
|--|----|
| Figure E.5 – H_x -field along the diagonal in dB for the 1 m × 1 m standard induction coil..... | 38 |
| Figure E.6 – H_x -field plot on y - z plane for the 1 m × 1 m standard induction coil..... | 38 |
| Figure E.7 – H_x -field plot on x - y plane for the 1 m × 1 m standard induction coil | 39 |
| Figure E.8 – H_x -field along the vertical middle line in dB for the 1 m × 2,6 m standard induction coil | 39 |
| Figure E.9 – H_x -field 2D-plot on y - z plane for the 1 m × 2,6 m standard induction coil..... | 40 |
| Figure E.10 – H_x -field 2D-plot on x - y plane at $z = 0,5$ m for the 1 m × 2,6 m standard induction coil | 40 |
| Table 1 – Test levels..... | 11 |
| Table 2 – Peak current specifications of the test system | 15 |
| Table 3 – Waveform specifications of the test system | 15 |
| Table D.1 – Example of uncertainty budget for the peak of the damped oscillatory current impulse (I_p) | 31 |
| Table D.2 – α factor (see equation (D.6)) of different unidirectional impulse responses corresponding to the same bandwidth of the system B | 33 |
| Table D.3 – β factor (equation (D.12)) of the damped oscillatory waveform..... | 34 |

INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTROMAGNETIC COMPATIBILITY (EMC) –

Part 4-10: Testing and measurement techniques – Damped oscillatory magnetic field immunity test

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as “IEC Publication(s)”). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

International Standard IEC 61000-4-10 has been prepared by subcommittee 77B: High frequency phenomena, of IEC technical committee 77: Electromagnetic compatibility.

It forms Part 4-10 of the IEC 61000 series. It has the status of a basic EMC publication in accordance with IEC Guide 107.

This second edition cancels and replaces the first edition published in 1993 and Amendment 1:2000. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) new Annex A on induction coil field distribution;
- b) new Annex D on measurement uncertainty;

- c) new Annex E for numerical simulations;
- d) calibration using current measurement has been addressed in this edition.

The text of this standard is based on the following documents:

| CDV | Report on voting |
|-------------|------------------|
| 77B/730/CDV | 77B/746A/RVC |

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61000 series, published under the general title *Electromagnetic compatibility (EMC)*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

INTRODUCTION

IEC 61000 is published in separate parts according to the following structure:

Part 1: General

General considerations (introduction, fundamental principles)

Definitions, terminology

Part 2: Environment

Description of the environment

Classification of the environment

Compatibility levels

Part 3: Limits

Emission limits

Immunity limits (insofar as they do not fall under the responsibility of the product committees)

Part 4: Testing and measurement techniques

Measurement techniques

Testing techniques

Part 5: Installation and mitigation guidelines

Installation guidelines

Mitigation methods and devices

Part 6: Generic standards

Part 9: Miscellaneous

Each part is further subdivided into several parts, published either as international standards or as technical specifications or technical reports, some of which have already been published as sections. Others will be published with the part number followed by a dash and a second number identifying the subdivision (example: IEC 61000-6-1).

This part is an international standard which gives immunity requirements and test procedures related to "damped oscillatory magnetic field".

ELECTROMAGNETIC COMPATIBILITY (EMC) –

Part 4-10: Testing and measurement techniques – Damped oscillatory magnetic field immunity test

1 Scope and object

This part of IEC 61000 specifies the immunity requirements, test methods, and range of recommended test levels for equipment subjected to damped oscillatory magnetic disturbances related to medium voltage and high voltage sub-stations.

The test defined in this standard is applied to equipment which is intended to be installed in locations where the phenomenon as specified in Clause 4 will be encountered.

This standard does not specify disturbances due to capacitive or inductive coupling in cables or other parts of the field installation. IEC 61000-4-18, which deals with conducted disturbances, covers these aspects.

The object of this standard is to establish a common and reproducible basis for evaluating the performance of electrical and electronic equipment for medium voltage and high voltage sub-stations when subjected to damped oscillatory magnetic fields.

The test is mainly applicable to electronic equipment to be installed in H.V. sub-stations. Power plants, switchgear installations, smart grid systems may also be applicable to this standard and may be considered by product committees.

NOTE As described in IEC Guide 107, this is a basic EMC publication for use by product committees of the IEC. As also stated in Guide 107, the IEC product committees are responsible for determining whether this immunity test standard is applied or not, and if applied, they are responsible for determining the appropriate test levels and performance criteria. TC 77 and its sub-committees are prepared to co-operate with product committees in the evaluation of the value of particular immunity test levels for their products.

This standard defines:

- a range of test levels;
- test equipment;
- test setups;
- test procedures.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050 (all parts), *International Electrotechnical Vocabulary (IEV)* (available at www.electropedia.org)

3 Terms, definitions and abbreviated terms

3.1 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 60050 as well as the following apply.

3.1.1

calibration

set of operations which establishes, by reference to standards, the relationship which exists, under specified conditions, between an indication and a result of a measurement

Note 1 to entry: This term is based on the "uncertainty" approach.

Note 2 to entry: The relationship between the indications and the results of measurement can be expressed, in principle, by a calibration diagram.

[SOURCE: IEC 60050-311:2001, 311-01-09]

3.1.2

damped oscillatory wave generator

generator delivering a damped oscillation whose frequency can be set to 100 kHz or 1 MHz and whose damping time constant is five periods

3.1.3

immunity

ability of a device, equipment or system to perform without degradation in the presence of an electromagnetic disturbance

[SOURCE: IEC 60050-161:1990, 161-01-20]

3.1.4

induction coil

conductor loop of defined shape and dimensions, in which a current flows, generating a magnetic field of defined uniformity in a defined volume

3.1.5

induction coil factor

ratio between the magnetic field strength generated by an induction coil of given dimensions and the corresponding current value

Note 1 to entry: The field is that measured at the centre of the coil plane, without the EUT.

3.1.6

proximity method

method of application of the magnetic field to the EUT, where a small induction coil is moved along the side of the EUT in order to detect particularly sensitive areas

3.1.7

reference ground

part of the Earth considered as conductive, the electrical potential of which is conventionally taken as zero, being outside the zone of influence of any earthing (grounding) arrangement

[SOURCE: IEC 60050-195:1998, 195-01-01]

This is a free preview. Purchase the entire publication at the link below:

[Product Page](#)

-
- [Looking for additional Standards? Visit Intertek Inform Infostore](#)
 - [Learn about LexConnect, All Jurisdictions, Standards referenced in Australian legislation](#)
-